

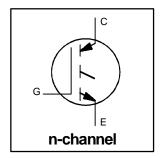
# IRGBF20F

### INSULATED GATE BIPOLAR TRANSISTOR

Fast Speed IGBT

#### **Features**

- Switching-loss rating includes all "tail" losses
- Optimized for medium operating frequency (1 to 10kHz) See Fig. 1 for Current vs. Frequency curve



$$V_{CES} = 900V$$
 
$$V_{CE(sat)} \le 4.3V$$
 
$$@V_{GE} = 15V, I_C = 5.3A$$

### **Description**

Insulated Gate Bipolar Transistors (IGBTs) from International Rectifier have higher usable current densities than comparable bipolar transistors, while at the same time having simpler gate-drive requirements of the familiar power MOSFET. They provide substantial benefits to a host of high-voltage, high-current applications.



### **Absolute Maximum Ratings**

	Parameter	Max.	Units
V <sub>CES</sub>	Collector-to-Emitter Voltage	900	V
I <sub>C</sub> @ T <sub>C</sub> = 25°C	Continuous Collector Current	9.0	
I <sub>C</sub> @ T <sub>C</sub> = 100°C	Continuous Collector Current	5.3	Α
I <sub>CM</sub>	Pulsed Collector Current ①	18	
I <sub>LM</sub>	Clamped Inductive Load Current ②	18	
$V_{GE}$	Gate-to-Emitter Voltage	±20	V
E <sub>ARV</sub>	Reverse Voltage Avalanche Energy 3	5.0	mJ
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Maximum Power Dissipation	60	W
P <sub>D</sub> @ T <sub>C</sub> = 100°C	Maximum Power Dissipation	24	
$T_{J}$	Operating Junction and	-55 to +150	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

#### **Thermal Resistance**

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	_	_	2.1	
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	_	0.50	_	°C/W
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	_	_	80	
Wt	Weight	_	2.0 (0.07)	_	g (oz)



# Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	900		_	V	$V_{GE} = 0V, I_{C} = 250\mu A$	
V <sub>(BR)ECS</sub>	Emitter-to-Collector Breakdown Voltage 4	20	_	_	V	$V_{GE} = 0V, I_{C} = 1.0A$	
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	_	0.85	_	V/°C	$V_{GE} = 0V, I_{C} = 1.0 \text{mA}$	
V <sub>CE(on)</sub>	Collector-to-Emitter Saturation Voltage	_	2.9	4.3		$I_{\rm C} = 5.3 A$	$V_{GE} = 15V$
		_	3.5	_	V	$I_{C} = 9.0A$	See Fig. 2, 5
		_	3.5	_		$I_C = 5.3A, T_J = 150$ °C	
V <sub>GE(th)</sub>	Gate Threshold Voltage	3.0		5.5		$V_{CE} = V_{GE}$ , $I_C = 250\mu A$	
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	_	-10	_	mV/°C	$V_{CE} = V_{GE}$ , $I_C = 250\mu A$	
g <sub>fe</sub>	Forward Transconductance ⑤	0.9	1.5	_	S	$V_{CE} = 100V, I_{C} = 5.3A$	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	_		250	μΑ	$V_{GE} = 0V, V_{CE} = 900V$	
		_	_	1000		$V_{GE} = 0V, V_{CE} = 900V,$	T <sub>J</sub> = 150°C
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	_	_	±100	nA	$V_{GE} = \pm 20V$	

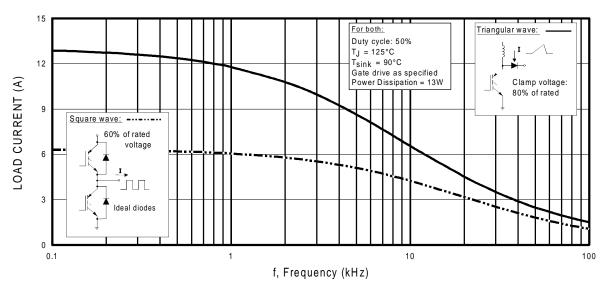
# Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

			•					
	Parameter	Min.	Тур.	Max.	Units	Conditions		
$Q_g$	Total Gate Charge (turn-on)	_	11	17		I <sub>C</sub> = 5.3A		
$Q_{ge}$	Gate - Emitter Charge (turn-on)	<u> </u>	2.6	3.9	nC	V <sub>CC</sub> = 400V See Fig. 8		
Q <sub>gc</sub>	Gate - Collector Charge (turn-on)	_	4.6	6.9		$V_{GE} = 15V$		
t <sub>d(on)</sub>	Turn-On Delay Time	_	29	_		T <sub>J</sub> = 25°C		
t <sub>r</sub>	Rise Time	_	12	_	ns	$I_C = 5.3A$ , $V_{CC} = 720V$		
t <sub>d(off)</sub>	Turn-Off Delay Time	_	170	300		$V_{GE} = 15V$ , $R_G = 50\Omega$		
t <sub>f</sub>	Fall Time	_	120	280		Energy losses include "tail"		
Eon	Turn-On Switching Loss	_	0.25	_				
E <sub>off</sub>	Turn-Off Switching Loss	_	0.36	_	mJ	See Fig. 9, 10, 11, 14		
E <sub>ts</sub>	Total Switching Loss	_	0.61	1.10				
t <sub>d(on)</sub>	Turn-On Delay Time	_	27	_		$T_{J} = 150^{\circ}C,$		
t <sub>r</sub>	Rise Time	_	13	_	ns	$I_C = 5.3A$ , $V_{CC} = 720V$		
t <sub>d(off)</sub>	Turn-Off Delay Time	_	270	_		$V_{GE} = 15V$ , $R_G = 50\Omega$		
t <sub>f</sub>	Fall Time	_	240	_		Energy losses include "tail"		
E <sub>ts</sub>	Total Switching Loss	_	1.10	_	mJ	See Fig. 10, 14		
LE	Internal Emitter Inductance	_	7.5	_	nΗ	Measured 5mm from package		
Cies	Input Capacitance	_	220	_		V <sub>GE</sub> = 0V		
Coes	Output Capacitance	_	25	_	pF	V <sub>CC</sub> = 30V See Fig. 7		
C <sub>res</sub>	Reverse Transfer Capacitance	_	3.4	_		f = 1.0MHz		

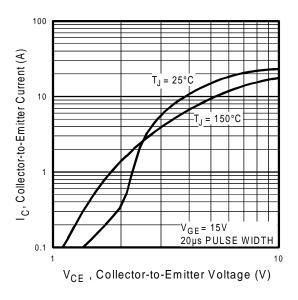
#### Notes:

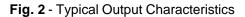
- 1 Repetitive rating; V  $_{\text{GE}}$ =20V, pulse width limited by max. junction temperature. ( See fig. 13b )
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- S Pulse width 5.0µs, single shot.

- $@~V_{CC}\!\!=\!\!80\%(V_{CES}),~V_{GE}\!\!=\!\!20V,~L\!\!=\!\!10\mu H,~R_{G}\!\!=\!50\Omega,~(~See~fig.~13a~)$
- 4 Pulse width  $\leq$  80 $\mu$ s; duty factor  $\leq$  0.1%.



**Fig. 1** - Typical Load Current vs. Frequency (For square wave,  $I=I_{RMS}$  of fundamental; for triangular wave,  $I=I_{PK}$ )





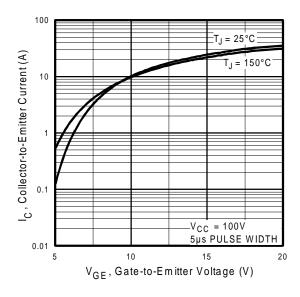


Fig. 3 - Typical Transfer Characteristics

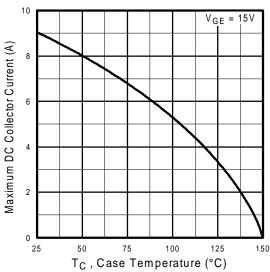
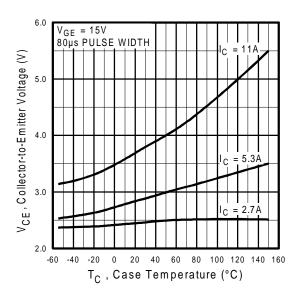


Fig. 4 - Maximum Collector Current vs.
Case Temperature



**Fig. 5** - Collector-to-Emitter Voltage vs. Case Temperature

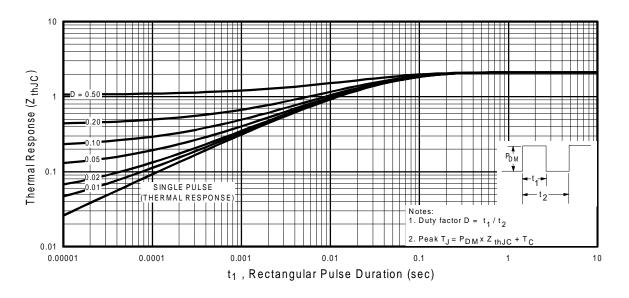
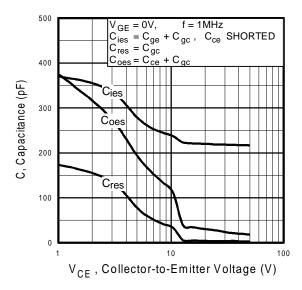
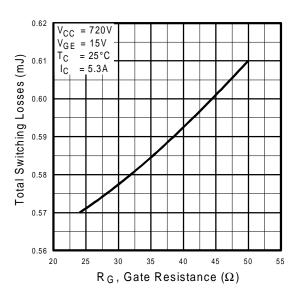


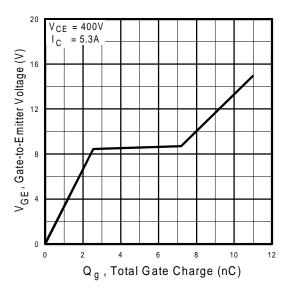
Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



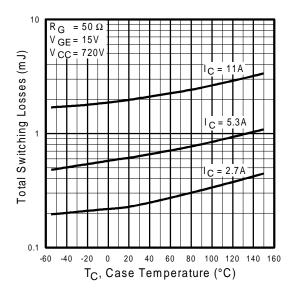
**Fig. 7 -** Typical Capacitance vs. Collector-to-Emitter Voltage



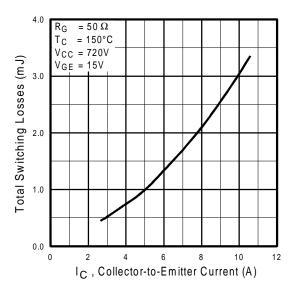
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



**Fig. 10** - Typical Switching Losses vs. Case Temperature



**Fig. 11 -** Typical Switching Losses vs. Collector-to-Emitter Current

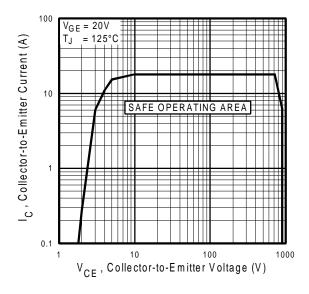


Fig. 12 - Turn-Off SOA

# Refer to Section D for the following:

### Appendix F: Section D - page D-8

Fig. 13a - Clamped Inductive Load Test Circuit

Fig. 13b - Pulsed Collector Current Test Circuit

Fig. 14a - Switching Loss Test Circuit

Fig. 14b - Switching Loss Waveform

Package Outline 1 - JEDEC Outline TO-220AB Section

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Note: For the most current drawings please refer to the IR website at: <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>